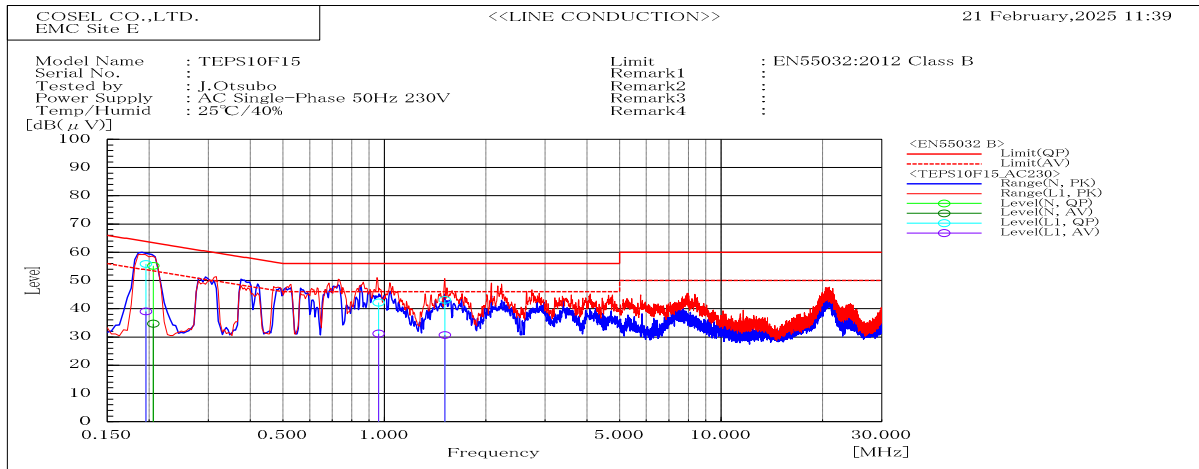
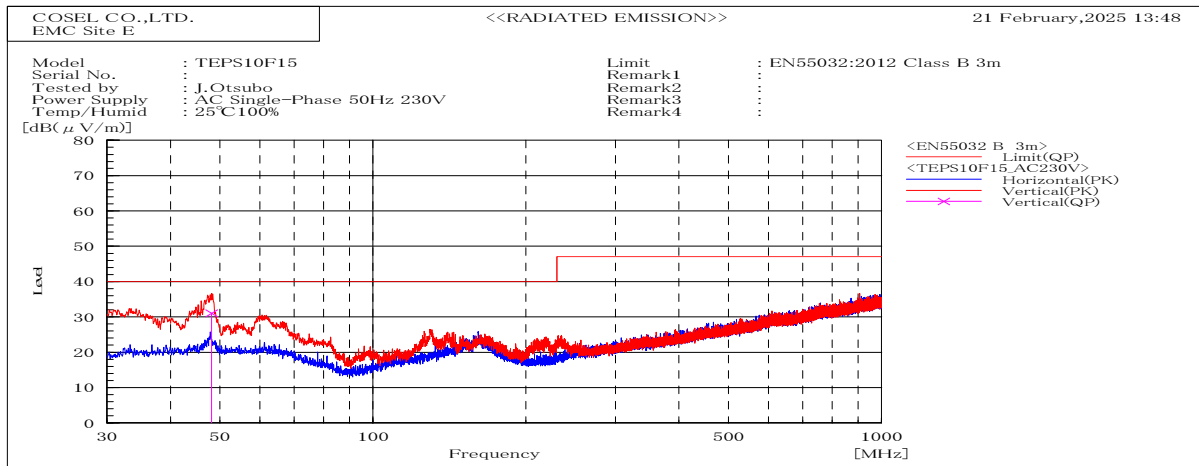


DATA SHEET		Date	24-Mar-25
Model	TEPS10F15	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma



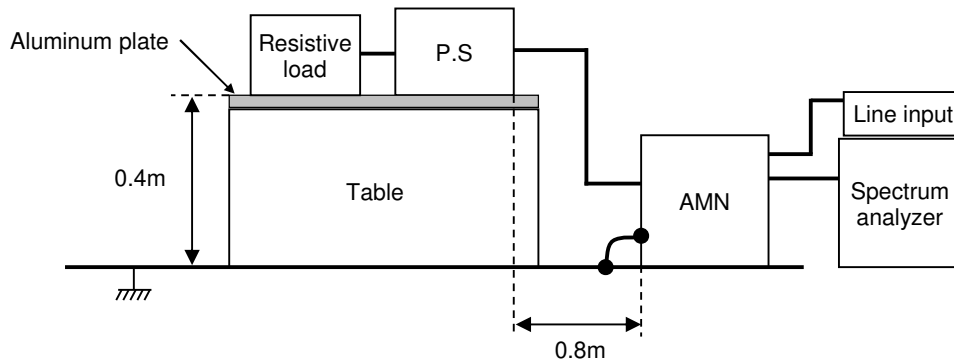
Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.196	L1	55.9	39	63.8	53.8	7.9	14.8	Pass	
0.961	L1	42.2	31.2	56	46	13.8	14.8	Pass	
1.513	L1	43.2	30.7	56	46	12.8	15.3	Pass	
0.206	N	55.2	34.7	63.4	53.4	8.2	18.7	Pass	



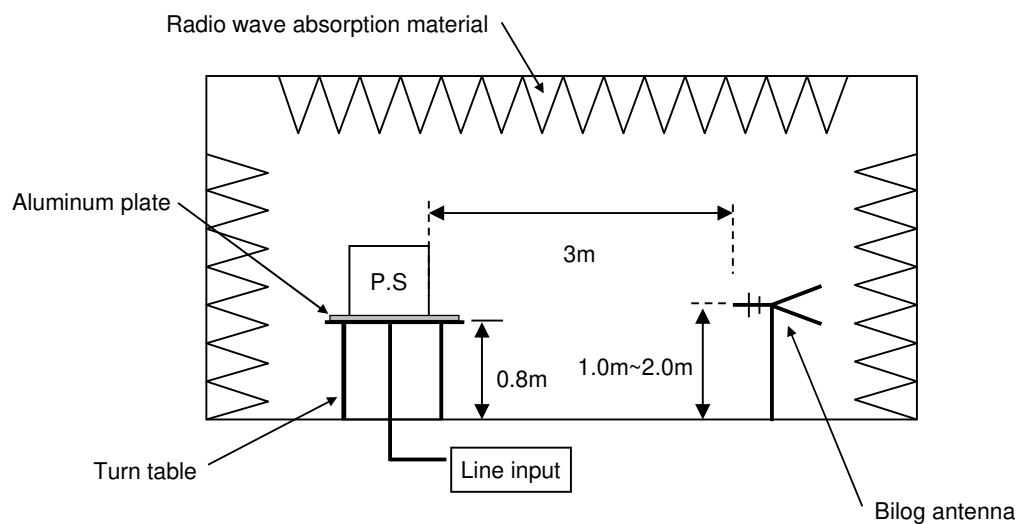
Frequency	Polarization	Stability	Level	Limit	Margin	Pass/Fail	Height	Angle	Remark
MHz			dB(μV/m)	dB(μV/m)	dB		cm	deg	
			QP	QP	QP				
48.186	V	Stable	31	40	9	Pass	100	290.6	

DATA SHEET		Date	24-Mar-25
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma

### 1. Line conduction



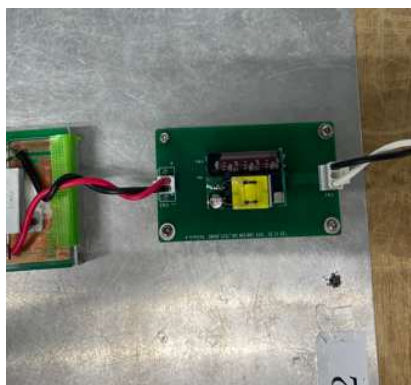
### 2. Radiated emission



## Conditions

Test : EMI  
Model Name : TEPS10F15

### 1.LINE CONDUCTION



### 2.RADIATED EMISSION

